SADAATL 2014

COLING Workshop on Synchronic and Diachronic Approaches to Analyzing Technical Language

Proceedings of the Workshop

August 24, 2014 Dublin, Ireland

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Proceedings of the COLING Workshop on Synchronic and Diachronic Approaches to Analyzing Technical Language (SADAATL 2014) Adam Meyers, Yifan He and Ralph Grishman (eds.)

Introduction

The Coling 2014 Workshop on Synchronic and Diachronic Approaches to Analyzing Technical Language was held on August 24, 2014 in Dublin Ireland.

Technology is the application of knowledge to practical pursuits. Information relevant to technology is the subject of various types of documents, including: scholarly publications (journals, conference proceedings, abstracts, grant applications, textbooks); legal documents (patents, contracts, legislation); and more public venues (magazines, webpages, blogs, financial reports). Interest in the automatic classification of technical documents has recently been growing and Natural Language Processing is a major component of such classification systems.

Presented at this workshop were six regular papers and two invited talks on various topics connected to the linguistic analysis of technical language including work on terminology, citations, Chinese-English Machine Translation, Sentiment Analysis, event extraction, literary analysis, named entity recognition, among other topics. Technical domains investigated included both patents and journal articles.

We thank the invited speakers, program committee, authors, Coling organizers and participants for a successful workshop.

Adam Meyers, Yifan He and Ralph Grishman

Co-Chairs

Adam Meyers, New York University, USA Yifan He, New York University, USA Ralph Grishman, New York University, USA

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Olga Babko-Malaya, BAE Systems, USA
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Marc Verhagen, Brandeis University, USA
Nianwen Xue, Brandeis University, USA

Invited Speakers

Sophia Ananiadou, University of Manchester, UK Simone Teufel, University of Cambridge, UK

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Program

9:30	Intro
9:45	Invited Talk by Sophia Ananiadou
10:30	Coffee Break
11:00	Investigating Context Parameters in Technology Term Recognition Behrang Q. Zadeh and Siegfried Handschuh
11:30	Jargon-Term Extraction by Chunking Adam Meyers, Zachary Glass, Angus Grieve-Smith, Yifan He, Shasha Liao and Ralph Grishman
12:00	Ontology-based Technical Text Annotation François Lévy, Nadi Tomeh and Yue Ma
12:30	Lunch Break
14:15	Invited Talk by Simone Teufel
15:00	Coffee Break
15:30	Extracting Aspects and Polarity from Patents Peter Anick, Marc Verhagen and James Pustejovsky
16:00	Pre-reordering Model of Chinese Special Sentences for Patent Machine Translation Renfen Hu, Zhiying Liu, Lijiao Yang and Yaohong Jin
16:30	A Study of Scientific Writing: Comparing Theoretical Guidelines with Practical Implementation Mark Kröll, Gunnar Schulze and Roman Kern
17:00	Closing